

## EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	1	10/743830	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/11/26 10:07
L2	146	356/237.1 and pattern near inspect\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/11/26 10:16
L3	0	(pattern and inspect\$3 and imag\$3 and sample and scann\$3 and region and (first and second) and measurement and compar\$5 and defects and position\$3 and recorgniz\$3 and control\$3).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/11/26 10:19
L4	0	(pattern and inspect\$3 and imag\$3 and sample and scann\$3 and (first and second) and measurement and compar\$5 and defects and position\$3 and recorgniz\$3 and control\$3).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/11/26 10:19
L5	4	(pattern and inspect\$3 and imag\$3 and sample and scann\$3 and (first and second) and measurement and compar\$5 and defects and position\$3 and control\$3).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/11/26 10:20
L6	4	(pattern and inspect\$3 and imag\$3 and sample and scann\$3 and (first and second) and measurement and compar\$5 and defects and position\$3 and control\$3).clm.	US-PGPUB; USPAT	OR	ON	2007/11/26 10:20

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